


FORM HDP-1449 (Based on Form PTO-1449) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Sheet 1 of 1	ATTORNEY DOCKET NO.	SERIAL NO.
	5077-000069/DVA	10/ 617, 198
	APPLICANT	
	Kenya Uomori et al.	
	FILING DATE	GROUP

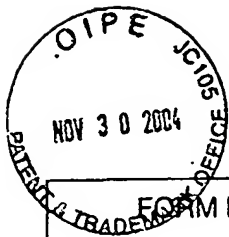
U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.	JL	4,294,544	10/1981	Altschuler et al.		—
2.	JL	4,427,880	01/1984	Kanade et al.		—
3.	JL	4,594,001	06/1986	DiMatteo et al.		—
4.	JL	4,687,325	08/1987	Corby, Jr., Nelson R.		—
5.	JL	4,867,570	09/1989	Sorimachi et al.		—
6.	JL	4,871,256	10/1989	Grindon, John R.		—
7.	JL	5,930,383	07/1999	Netzer, Yishay		—
8.	JL	6,392,744	05/2002	Holec, Henry V.		—
9.	JL	6,441,888	08/2002	Azuma et al.		—

FOREIGN PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes No
1.						

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	
1.	JL	Inokuchi, Seiji; "Recent trend of Development and Application in Range Imaging"; MVA '98 IAPR Workshop on Machine Vision Applications; pp. 359-366; November 17-19, 1998.

Examiner: 	Date Considered: 03-30-05
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EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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**PATENT AND TRADEMARK OFFICE
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(Use several sheets if necessary)

Sheet 1 of 1

ATTORNEY DOCKET No.

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10/617,198

APPLICANT

Kenya Uomori et al.

FILING DATE

July 10, 2003

GROUP

2877

U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	JL	11-023225	01/29/1999	Japan		Abstract	
2.	JL	04-241476	08/28/1992	Japan		Abstract	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.	JL	Notice of Reasons of Rejection for Japanese Patent Application No. 2001-286646; Mailed: August 31, 2004; and English translation.

Examiner

Date Considered:

03-30-05

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FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes No	
1.	JC	2000241131 A	09/08/2000	Japan		Abstract	
2.	J	08178632 A	07/12/1996	Japan		Abstract	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
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